NSN 6625-01-385-5880

Electronic Test Function Generator - Page 1 of 1



View Online at https://aerobasegroup.com/nsn/6625-01-385-5880

Inclosure Type:
Encased
Operating Control Method:
Manual
Circuit Construction Type:
Solid state
Special Features:
State and timing analysis data on all channels; 100 mhz state analysis rate; 102 channels/card, 204 channels/timebase; 4k/8k memory
depth/channel timing analysis rate (conventional - 250/500mhz, traditional - 125/250mhz, glitch - 125mhz)
Shelf Life:
N/a
Unit Of Measure:
Demilitarization:
No
Fiig:
A32200